Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/716,879	SCHEIER ET A	L.
Examiner	Art Unit	
ALEX LIEW	2624	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
Interfere	nce search	9/10/2008	AL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
345/156-184 limited to text search 382/103,115-118,124-127 limited to text search	9/10/2008	AL		
Inventor name search	9/10/2008	AL		